

Notice of References Cited	Application/Control No. 10/553,261	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner CATHERYNE CHEN	Art Unit 1655	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0006648 A1	07-2001	YAMAUCHI et al.	424/400
*	B	US-5,869,034	02-1999	Montastier et al.	424/78.03
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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